MOSFET – Power, Single, N-Channel, WDFN8

30 V, 64 A

Features

- Integrated Schottky Diode
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free and are RoHS Compliant

Applications

- CPU Power Delivery
- Synchronous Rectification for DC-DC Converters
- Low Side Switching
- Telecom Secondary Side Rectification

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Param	Symbol	Value	Unit		
Drain-to-Source Voltage	V_{DSS}	30	V		
Gate-to-Source Voltage	V_{GS}	±20	V		
Continuous Drain		T _A = 25°C	I _D	22	Α
Current R _{θJA} (Note 1)		T _A = 85°C		15.9	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	2.69	W
Continuous Drain		T _A = 25°C	I _D	32.4	Α
Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)		T _A = 85°C		23.4	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T _A = 25°C	P _D	5.85	W
Continuous Drain	State	T _A = 25°C	I _D	16.3	Α
Current R _{θJA} (Note 2)		T _A = 85°C		11.7	
Power Dissipation $R_{\theta JA}$ (Note 2)		T _A = 25°C	P _D	1.47	W
Continuous Drain		T _C = 25°C	I _D	64	Α
Current R _{θJC} (Note 1)		T _C = 85°C		46	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P _D	22.73	W
Pulsed Drain Current	T _A = 25°0	C, t _p = 10 μs	I _{DM}	192	Α
Operating Junction and S	T _J , T _{stg}	-55 to +150	°C		
Source Current (Body Did	I _S	32	Α		
Drain to Source dV/dt	dV/dt	6.0	V/ns		

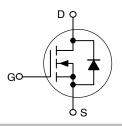


ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX	
30 V	3.5 mΩ @ 10 V	64 A	
30 V	5.2 mΩ @ 4.5 V	04 A	

N-Channel MOSFET





CASE 511AB

S

MARKING DIAGRAM

4985 = Specific Device Code
A = Assembly Location

Y = Year WW = Work Week

= Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFS4985NFTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Value	Unit
Single Pulse Drain–to–Source Avalanche Energy (T_J = 25°C, V_{DD} = 50 V, V_{GS} = 10 V, I_L = 32 A_{pk} , L = 0.1 mH, R_G = 25 Ω)	E _{AS}	52	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	T_L	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size of 90 $\mbox{mm}^2.$

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	5.5	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	46.4	
Junction-to-Ambient - Steady State (Note 4)	$R_{ heta JA}$	84.8	
Junction–to–Ambient – (t ≤ 10 s) (Note 3)	$R_{ heta JA}$	21.4	

- 3. Surface–mounted on FR4 board using 1 sq–in pad, 2 oz Cu.
- 4. Surface-mounted on FR4 board using the minimum recommended pad size of 90 mm².

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				15		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25°C			500	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = I_{DS}$	= 250 μΑ	1.2	1.6	2.3	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.2		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V 40V	I _D = 20 A		2.8	3.5	mΩ
	$V_{GS} = 10 \text{ V}$	I _D = 10 A		2.8			
		V 45V	I _D = 20 A		4.16	5.2	
	$V_{GS} = 4.5 \text{ V}$ $I_{D} = 10 \text{ A}$	I _D = 10 A		4.13			
Forward Transconductance	g _{FS}	V _{DS} = 1.5 V, I _D = 10 A			34		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}				2075		pF
Output Capacitance	C _{oss}	$V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}, V_{DS} = 15 \text{ V}$			876		
Reverse Transfer Capacitance	C _{rss}				46		
Total Gate Charge	Q _{G(TOT)}				13.6		nC
Threshold Gate Charge	Q _{G(TH)}	\			2.0		
Gate-to-Source Charge	Q_{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}, I_D = 20 \text{ A}$			5.8		
Gate-to-Drain Charge	Q_{GD}				4.1		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

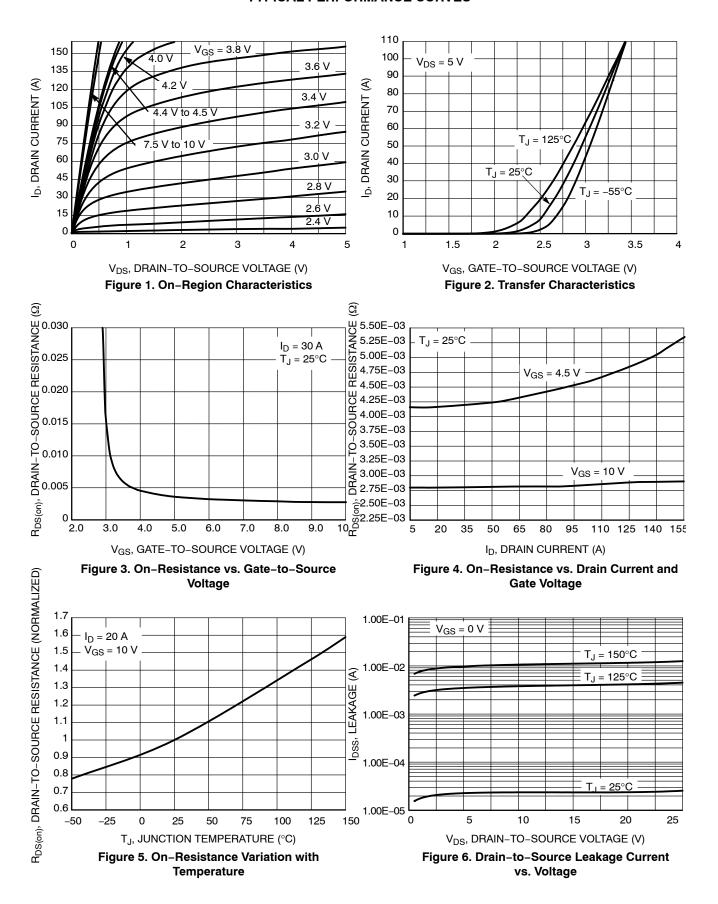
- 5. Pulse Test: pulse width = 300 μ s, duty cycle \leq 2%.
- 6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

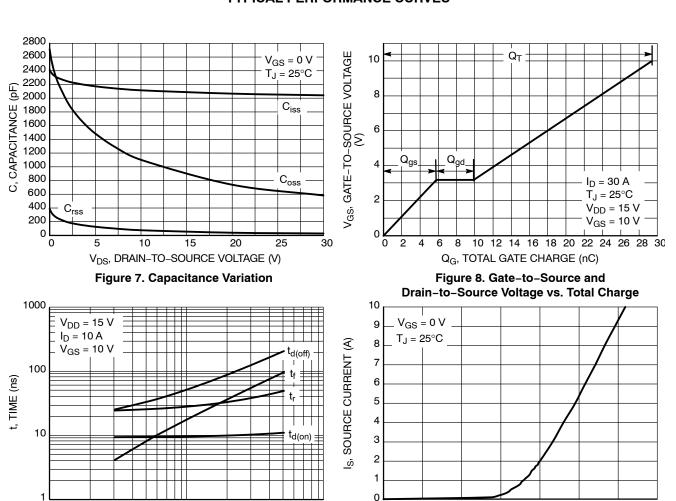
Parameter	Symbol	Test Condit	ion	Min	Тур	Max	Unit
CHARGES AND CAPACITANCES	6	•					
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V, I _D = 20 A			29.4		nC
SWITCHING CHARACTERISTICS	(Note 6)						
Turn-On Delay Time	t _{d(on)}				11		ns
Rise Time	t _r	V _{GS} = 4.5 V, V _{DS}	= 15 V,		24		1
Turn-Off Delay Time	t _{d(off)}	I _D = 15 A, R _G =	3.0 Ω		20		1
Fall Time	t _f	1			5.4		1
Turn-On Delay Time	t _{d(on)}	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			8.5		ns
Rise Time	t _r				24		1
Turn-Off Delay Time	t _{d(off)}				25		1
Fall Time	t _f				4.0		1
DRAIN-SOURCE DIODE CHARA	CTERISTICS				•	•	•
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V.	T _J = 25°C		0.4	0.7	V
		$V_{GS} = 0 \text{ V},$ $I_S = 2 \text{ A}$	T _J = 125°C		0.33		1
Reverse Recovery Time	t _{RR}		1		35.7		ns
Charge Time	ta	$V_{GS} = 0 \text{ V. } d_{1S}/d_{1S}$	100 A/us.		18.2		1
Discharge Time	t _b	$V_{GS} = 0 \text{ V, } d_{IS}/d_t = I_S = 2 \text{ A}$,,,		17.5		1
Reverse Recovery Charge	Q _{RR}	1			32		nC
PACKAGE PARASITIC VALUES	•					•	•
Source Inductance	L _S				0.65		nΗ
Drain Inductance	L _D		<u> </u>		0.20		
Gate Inductance	L _G	T _A = 25°C			1.5		1
Gate Resistance	R _G	1			1.0		Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width = $300 \, \mu s$, duty cycle $\leq 2\%$. 6. Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES



TYPICAL PERFORMANCE CURVES



100

0.0

0.1

0.2

 $\begin{aligned} & R_{G}, \, \text{GATE RESISTANCE} \; (\Omega) \\ & \textbf{Figure 9. Resistive Switching Time} \\ & \textbf{Variation vs. Gate Resistance} \end{aligned}$

10

1

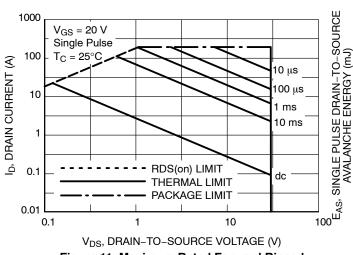


Figure 11. Maximum Rated Forward Biased Safe Operating Area



0.4

0.5

0.6

0.7

0.3

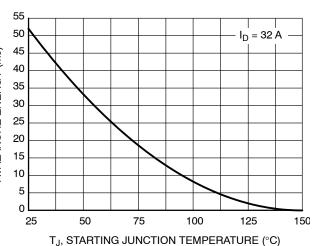


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL PERFORMANCE CURVES

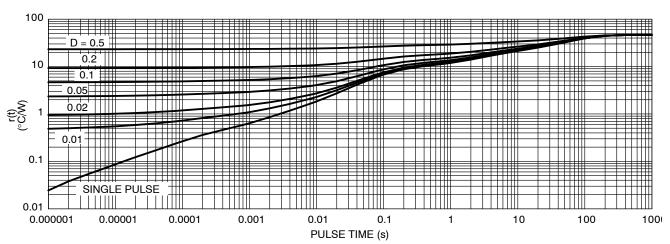


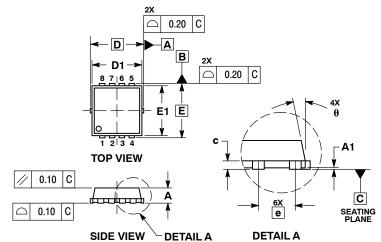
Figure 13. Thermal Response





WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

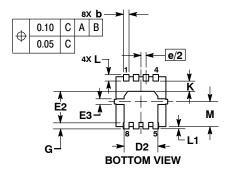
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NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

	MI	LLIMETE	RS	INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		0	.130 BSC)
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E		3.30 BSC		0	.130 BSC)
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е	0.65 BSC			(0.026 BS0	2
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °

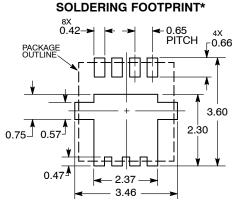


GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week = Pb-Free Package



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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^{*}This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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